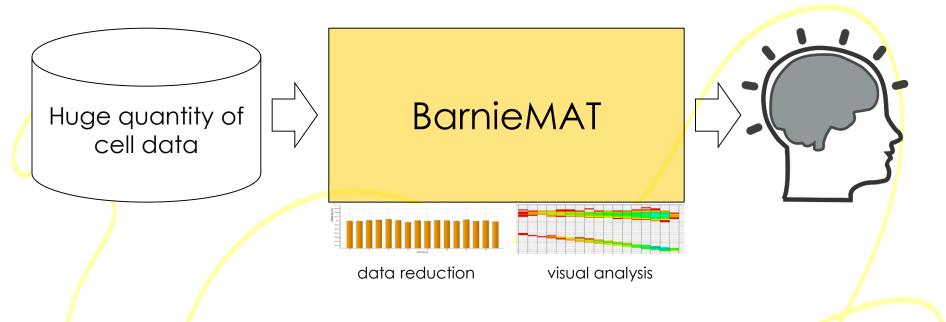
BarnieMAT Bitmap Analysis Software Product Presentation

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to

IVM

Fast Learning of Array Effects



- Unique industrial-level data processing tool, since 2007
- Used by 20+ memory makers and research institutes
- Covers all available test platforms and memory technologies.
 - SRAM, DRAM, NAND, NOR, RRAM, PCM, ...
 - SLC, MLC, 3D, embedded
 - Up to 64Gbit arrays, up to 256 levels per cell



BarnieMAT Applications

Technology Development	Design Validation, Characterization Qualification	Yield Learning Failure Analysis
Programmability	Endurance effects	Engineering analysis of high volume production
Disturb sensitivity	Retention effects	Pattern recognition
Distribution tail bits	Statistical fail analysis	BIST signature
Topologic signatures	Algorithm evaluation	

"Extremely fast analysis of qualification data" Senior Specialist, Infineon

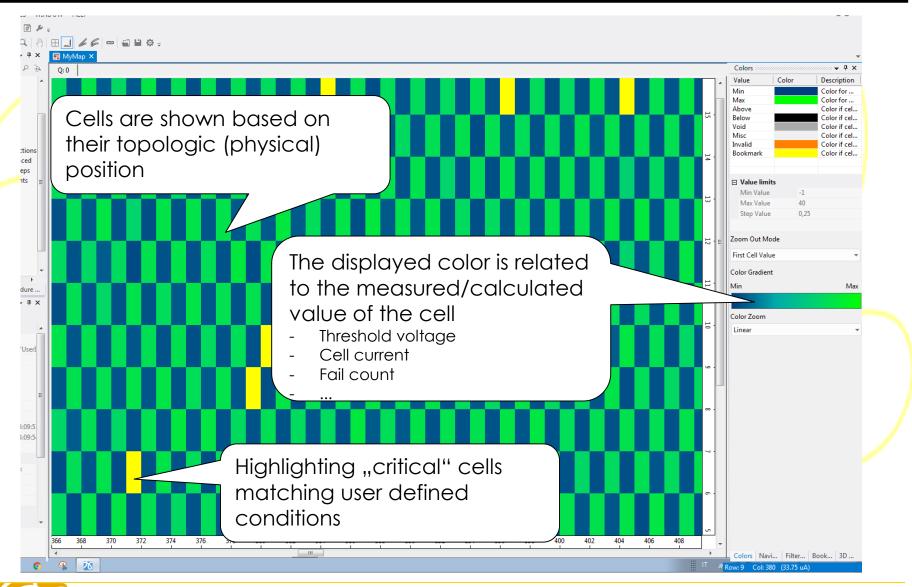


BarnieMAT

Best-in-class Presentation Tools

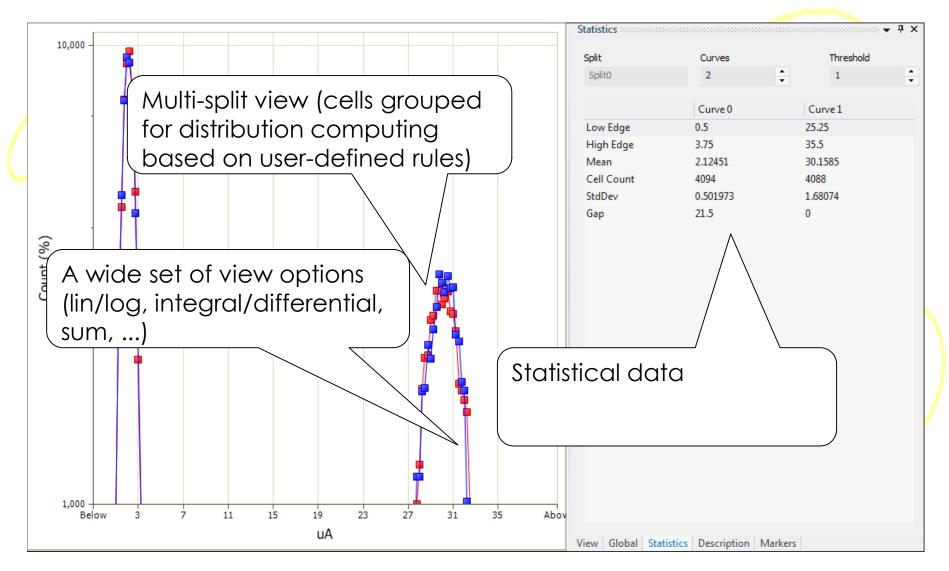
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Bitmap Viewer



BM20180905 Public Domain

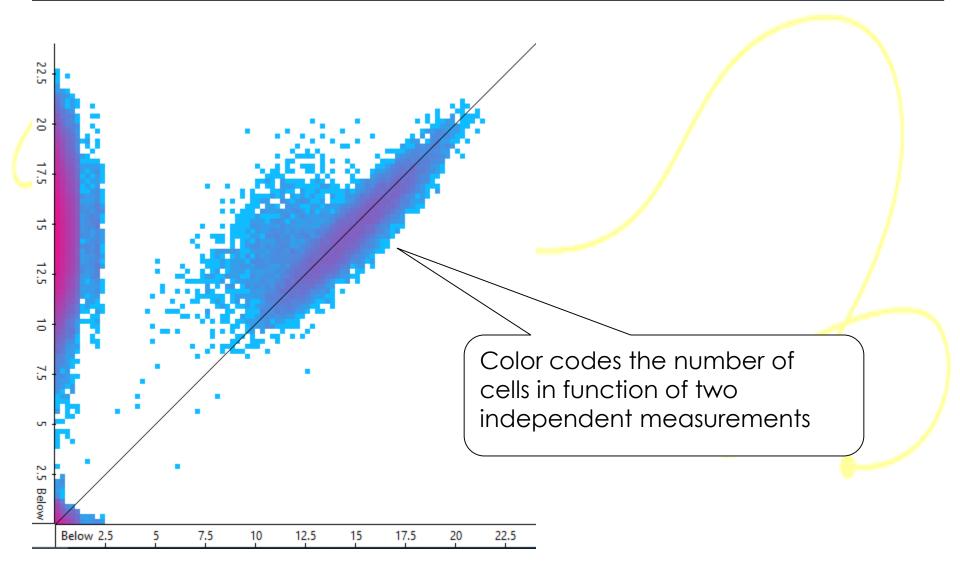
Distribution Analyzer





BM20180905 Public Domain

3D Distribution



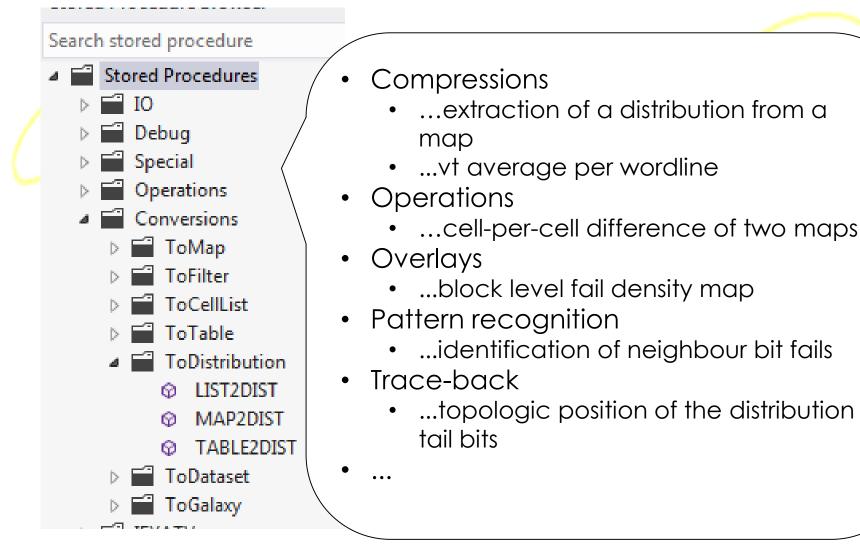


BarnieMAT

Advanced Processing Engine

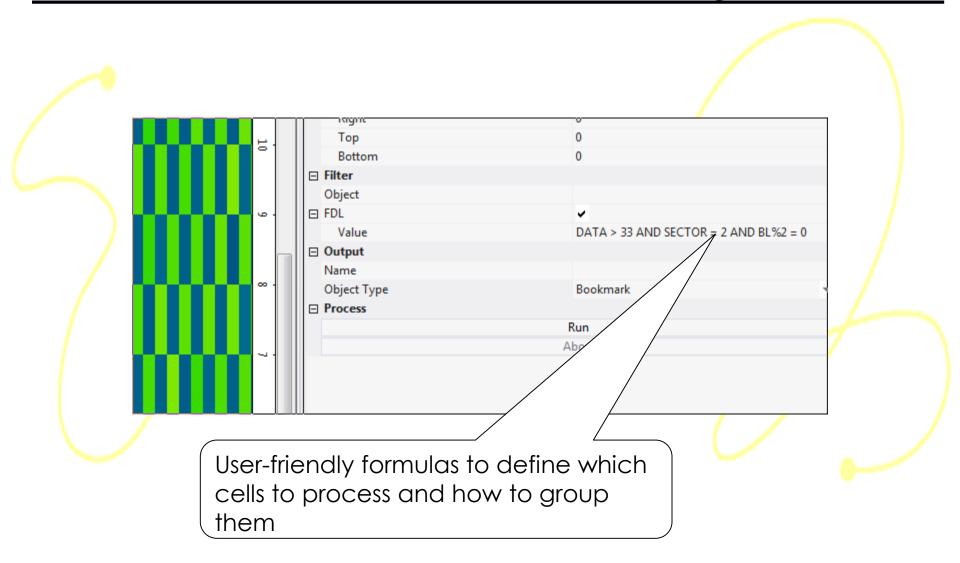
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Speed Optimized Processing Tools





Formula-Driven Computing





"Quite Big Data"

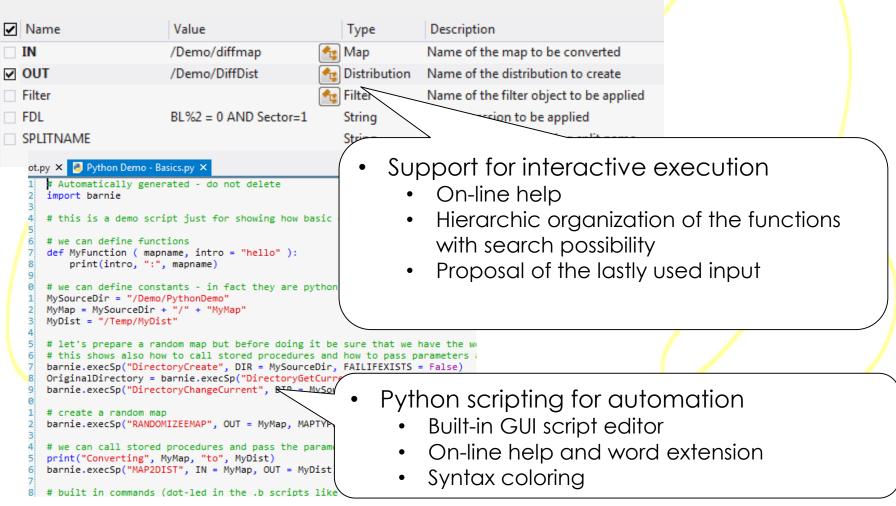
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12	12	Lot00		2	0		10	10	30.1254	
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Advanced Flow Automation

Kored Procedure MAP2DIST Parameters

Creates a multi-split distribution from a map using filtering





Customization and Integration

Task	What To Do			
Dedicated importers and exporters for proprietary data formats	C++ code with library support (off-line conversion to BarnieMAT format)			
Description of the device characteristics	C++ code XML configuration of templates			
Additional, user-specific processing tools	C++ code with library support			
Integration in a data processing environment	Use of the command line interface			
Real-time tester connection	TCP-IP based protocol, tester-side library available			



BarnieMAT supported by a skilled team of industry experts

- Contraction

or you time and consideration